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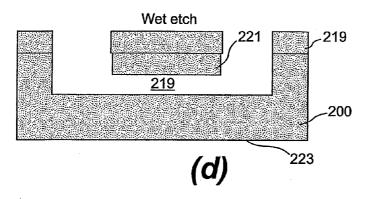
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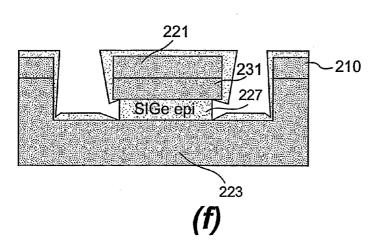
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[Continued on next page]

#### (54) Title: METHOD AND STRUCTURE FOR FORMING STRAINED SI FOR CMOS DEVICES





(57) Abstract: A method for manufacturing a device including an n-type device and a p-type device. In an aspect of the invention, the method involves doping a portion of a semiconductor substrate (200) and forming a gap (219) in the semiconductor substrate (200) by removing at least a portion of the doped portion of the semiconductor The method further substrate (200). involves growing a strain layer (227) in at least a portion of the gap (219) in the semiconductor substrate (200). For the n-type device, the strain layer (227) is grown on at least a portion which is substantially directly under a channel of the n-type device. For the p-type device, the strain layer is grown on at least a portion which is substantially directly under a source region or drain region of the p-type device and not substantially under a channel of the p-type device.



# WO 2005/045901 A3



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## INTERNATIONAL SEARCH REPORT

International application No.

PCT/US04/37049

A. CLASSIFICATION OF SUBJECT MATTER  IPC(7) : H01L 21/38, 21/461, 21/47, 21/8238, 29/161, 29/772  US CL : 438/199, 218, 221, 514, 739, 766; 257/65, 288						
According to International Patent Classification (IPC) or to both national classification and IPC						
	DS SEARCHED					
Minimum documentation searched (classification system followed by classification symbols) U.S.: 438/199, 218, 221, 514, 739, 766; 257/65, 288						
Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched None						
Electronic data base consulted during the international search (name of data base and, where practicable, search terms used) USPAT; US PG PUBS; Derwent; EPO; JPO; IBM TDB						
	JMENTS CONSIDERED TO BE RELEVANT					
Category *	Citation of document, with indication, where a		Relevant to claim No.			
X	US 2002/0086472 A1 (Roberds et al.) 04 July 2002 (	(04.07.2002), Figs. 1-7, paragraphs	1-2, 7, 17-18, 24-26			
Υ .	[0020] to [0043].		5-6, 8-14			
X, E	US 6,825,086 B2 (Lee et al.) 30 November 2004 (30 line 46 to column 5, line 50.	.11.2004), Figs. 1-4, 9, 11 and column 2,	1,18-19, 23			
X, E	US 6,891,192 B2 (Chen et al.) 10 May 2005 (10.05.2005), Figs. 3-9 and column 2, line 52 to column 7, line 10.		1, 3-4, 8-12, 15, 18, 24- 33, 35-36			
Y, E			16			
Y	US 2001/0003364 A1 (Sugawara et al.) 14 June 2001 (14.06.2001), paragraphs [0023], [0024], [0040], and [0042].		5-6, 8-14			
Y, P	US 6,703,293 B2 (Tweet et al.) 09 March 2004 (09.03.2004), column 4, line 66 to column 5, line 20.		16			
A	US 2003/0087492 A1 (Lee et al.) 08 May 2003 (08.05.2003), abstract.		1-36			
Further	documents are listed in the continuation of Box C.	See patent family annex.				
* Sp	pecial categories of cited documents:	"T" later document published after the inter date and not in conflict with the applica				
"A" document particular	defining the general state of the art which is not considered to be of relevance	principle or theory underlying the inven	ition			
"E" earlier app	olication or patent published on or after the international filing date	"X" document of particular relevance; the cl considered novel or cannot be considered when the document is taken alone				
	which may throw doubts on priority claim(s) or which is cited to he publication date of another citation or other special reason (as	"Y" document of particular relevance; the cl considered to involve an inventive step combined with one or more other such	when the document is			
"O" document	referring to an oral disclosure, use, exhibition or other means	being obvious to a person skilled in the				
"P" document published prior to the international filing date but later than the priority date claimed		"&" document member of the same patent family				
Date of the actual completion of the international search		Date of mailing of the international search report 7 JAN 2006				
	05 (03.10.2005) iling address of the ISA/US	Authorized officer o				
	Stop PCT, Attn: ISA/US	Stanban W. Small Dudlle Deck T				
Commissioner for Patents P.O. Box 1450		Stephen W. Smoot  Stephen W. Smoot				
	andria, Virginia 22313-1450	Telephone No. 571-272-1698	for 1			
Facsimile No. (703) 305-3230						

Form PCT/ISA/210 (second sheet) (April 2005)

## INTERNATIONAL SEARCH REPORT

International application No.

PCT/US04/37049

Box No. II	Observations where certain claims were found unsearchable (Continuation of item 2 of first sheet)			
This international search report has not been established in respect of certain claims under Article 17(2)(a) for the following reasons:				
1.	Claims Nos.: because they relate to subject matter not required to be searched by this Authority, namely:			
2.	Claims Nos.: because they relate to parts of the international application that do not comply with the prescribed requirements to such an extent that no meaningful international search can be carried out, specifically:			
3.	Claims Nos.: because they are dependent claims and are not drafted in accordance with the second and third sentences of Rule 6.4(a).			
Box No. III	Observations where unity of invention is lacking (Continuation of item 3 of first sheet)			
This International Searching Authority found multiple inventions in this international application, as follows: Please See Continuation Sheet				
1.	As all required additional search fees were timely paid by the applicant, this international search report covers all searchable claims.  As all searchable claims could be searched without effort justifying additional fees, this Authority did not invite payment of any additional fees.  As only some of the required additional search fees were timely paid by the applicant, this international search report covers only those claims for which fees were paid, specifically claims Nos.:			
4. Remark on P	No required additional search fees were timely paid by the applicant. Consequently, this international search report is restricted to the invention first mentioned in the claims; it is covered by claims Nos.:  The additional search fees were accompanied by the applicant's protest and, where applicable, the payment of a protest fee.  The additional search fees were accompanied by the applicant's protest but the applicable protest fee was not paid within the time limit specified in the invitation.  No protest accompanied the payment of additional search fees.			

Form PCT/ISA/210 (continuation of first sheet(2)) (April 2005)

INTERNATIONAL SEARCH REPORT	International application No. PCT/US04/37049	
BOX III. OBSERVATIONS WHERE UNITY OF INVENTION IS LACKING This International Search Authority has found 3 inventions claimed in the Internation below.	NG nal Application covered by the claims as indicated	
This application contains the following inventions or groups of inventions which are not so linked as to form a single general inventive concept under PCT Rule 13.1. In order for all inventions to be examined, the appropriate additional examination fees must be paid.		
Group I, claims 1-23, drawn to a process.		
Group II, claims 24-36, drawn to a device.		
The claims are deemed to correspond to the species listed above in the following man	nner:	
Group I, species 1, claims 1-18 drawn to forming a gap by removing a portion of the substrate.		
Group I, species 2, claims 19-23 drawn to forming a gap by removing a portion of the	e layer above the substrate.	
The following claims are generic: none.		
This International Search Authority considers that the International Application does invention (Rules 13.1, 13.2, and 13.3) for the following reason.	not comply with the requirements of unity of	
The inventions listed as Groups I and II and species 1 and 2 do not relate to a single g because, under PCT Rule 13.2, they lack the same or corresponding special technical strained layer in a trench is not a special technical feature because it has already been 2003/0087492 A1, in which a strained SiGe layer is disclosed (see abstract). Accorditechnical feature and unity is lacking.	features for the following reasons: the forming of a established in the art, as evidenced for example by US	